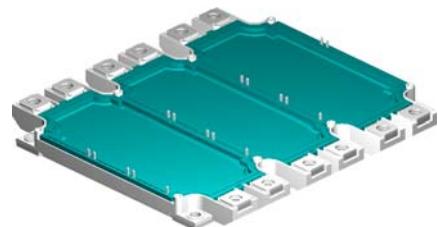
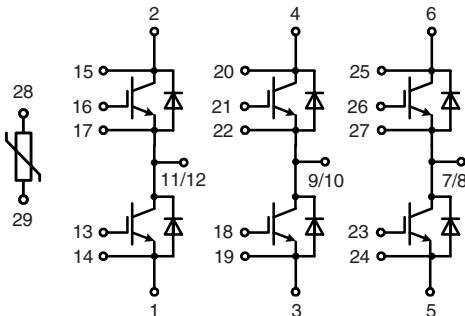


# IGBT Modules

## Sixpack

### NPT<sup>3</sup> IGBT

**I<sub>C80</sub>** = 375 A  
**V<sub>CES</sub>** = 1200 V  
**V<sub>CE(sat) typ.</sub>** = 2.0 V



#### IGBTs

Symbol	Conditions	Maximum Ratings		
V <sub>CES</sub>	T <sub>VJ</sub> = 25°C to 125°C	1200		V
V <sub>GES</sub>		± 20		V
I <sub>C25</sub>	T <sub>C</sub> = 25°C	530		A
I <sub>C80</sub>	T <sub>C</sub> = 80°C	375		A
RBSOA	R <sub>G</sub> = 3.3 Ω; T <sub>VJ</sub> = 125°C Clamped inductive load; L = 100 μH	I <sub>CM</sub> = 750 V <sub>CEK</sub> ≤ V <sub>CES</sub>		A
t <sub>sc</sub> (SCSOA)	V <sub>CE</sub> = 900 V; V <sub>GE</sub> = ±15 V; R <sub>G</sub> = 3.3 Ω; T <sub>VJ</sub> = 125°C; non-repetitive; V <sub>CEmax</sub> ≤ V <sub>CES</sub>	10		μs
P <sub>tot</sub>	T <sub>C</sub> = 25°C	2.1		kW

Symbol	Conditions	Characteristic Values		
		(T <sub>VJ</sub> = 25°C, unless otherwise specified)	min.	typ.
V <sub>CE(sat)</sub>	I <sub>C</sub> = 300 A; V <sub>GE</sub> = 15 V; T <sub>VJ</sub> = 25°C T <sub>VJ</sub> = 125°C		2 2.2	2.4 2.7 V
V <sub>GE(th)</sub>	I <sub>C</sub> = 12 mA; V <sub>GE</sub> = V <sub>CE</sub>	4.5		6.5 V
I <sub>CES</sub>	V <sub>CE</sub> = V <sub>CES</sub> ; V <sub>GE</sub> = 0 V; T <sub>VJ</sub> = 25°C T <sub>VJ</sub> = 125°C		0.4 1	1 12 mA
I <sub>GES</sub>	V <sub>CE</sub> = 0 V; V <sub>GE</sub> = ± 20 V			600 nA
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> E <sub>on</sub> E <sub>off</sub>	Inductive load, T <sub>VJ</sub> = 125°C V <sub>CE</sub> = 600 V; I <sub>C</sub> = 300 A V <sub>GE</sub> = ±15 V; R <sub>G</sub> = 3.3 Ω		330	ns
			20	ns
			750	ns
			50	ns
			36	mJ
			30	mJ
C <sub>ies</sub>	V <sub>CE</sub> = 25 V; V <sub>GE</sub> = 0 V; f = 1 MHz	22		nF
Q <sub>Gon</sub>	V <sub>CE</sub> = 600 V; V <sub>GE</sub> = 15 V; I <sub>C</sub> = 450 A	2.3		μC
R <sub>thJC</sub>			0.06	K/W

IXYS reserves the right to change limits, test conditions and dimensions.

**Diodes**

Symbol	Conditions	Maximum Ratings		
$I_{F80}$	$T_C = 80^\circ\text{C}$	300	A	
$I_{FRM}$	$t_p = 1 \text{ ms}$	600	A	

Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
$V_F$	$I_F = 300 \text{ A}; V_{GE} = 0 \text{ V}; T_{VJ} = 25^\circ\text{C}$		2	V
$I_{RM}$	$I_F = 300 \text{ A}; dI_F/dt = 2700 \text{ A}/\mu\text{s}; T_{VJ} = 125^\circ\text{C}; V_R = 800 \text{ V}$	240		A
$R_{thJC}$		0.11		K/W

**Temperature Sensor NTC**

Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
$R_{25}$	$T = 25^\circ\text{C}$	4.75	5.0	$5.25 \text{ k}\Omega$
$B_{25/50}$			3375	K

**Module**

Symbol	Conditions	Maximum Ratings		
$T_{VJ}$	operating	-40...+125	$^\circ\text{C}$	
$T_{JM}$		+150	$^\circ\text{C}$	
$T_{stg}$		-40...+125	$^\circ\text{C}$	
$V_{ISOL}$	$I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$	2500	V~	
$M_d$	Mounting torque (M5) Terminal connection torque (M6)	3 - 6	Nm	
		3 - 6	Nm	

Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
$R_{term-chip}^*)$	Resistance terminal to chip	0.55	$\text{m}\Omega$	
$d_s$	Creepage distance on surface	12.7		mm
$d_A$	Strike distance in air	10		mm
$R_{thCH}$	with heatsink compound	0.01		K/W
<b>Weight</b>		900		g

<sup>\*)</sup>  $V = V_{CE(\text{sat})} + 2x R_{term-chip} \cdot I_C$  resp.  $V = V_F + 2x R_{term-chip} \cdot I_F$

Dimensions in mm (1 mm = 0.0394")

